Renesas

MOS FIELD EFFECT TRANSISTOR

μ PA2793AGR

SWITCHING N- AND P-CHANNEL POWER MOS FET

DESCRIPTION

The µPA2793AGR is N- and P-channel MOS Field Effect Transistors designed for Motor Drive application.

FEATURES

- Low on-state resistance
- N-channel $R_{DS(on)1} = 15 \text{ m}\Omega \text{ MAX}$. (Vgs = 10 V, ID = 3.5 A) $R_{DS(on)2} = 23 \text{ m}\Omega \text{ MAX.}$ (Vgs = 4.5 V, ID = 3.5 A) P-channel R_{DS(on)1} = 26 m Ω MAX. (V_{GS} = -10 V, I_D = -3.5 A)

 $R_{DS(on)2} = 36 \text{ m}\Omega \text{ MAX.}$ (Vgs = -4.5 V, ID = -3.5 A)

Low input capacitance

N-channel Ciss = 2200 pF TYP.

- P-channel Ciss = 2200 pF TYP.
- Built-in gate protection diode
- Small and surface mount package (Power SOP8)

ORDERING INFORMATION							
PART NUMBER	LEAD PLATING	PACKING	PACKAGE				
μPA2793AGR-E1-AT ^{Note}							
μPA2793AGR-E2-AT ^{Note}	Pure Sn	Tape 2500 p/reel	Power SOP8				

Note Pb-free (This product does not contain Pb in external electrode and other parts.)

EQUIVALENT CIRCUITS

N-channel P-channel Drain Drain Body Body Gate Diode Gate Diode Gate Gate Protection Protection Source Source Diode Diode

Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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Å A B Ĕ N-channel Source 1 1 2 : Gate 1 7, 8: Drain 1 P-channel 3 Source 2 Gate 2 5, 6: Drain 2 ()Ħ 6.0 ± 0.3 4.4 5.37 MAX. 0.8 4 .8 MAX Ϋ́ ŝ Ċ 0.5 ±0.2 MIN 0.10 \square 1.27 0.78 MAX. 0.05 0.40 ^{+0.10} \oplus 0.12 M

PACKAGE DRAWING (Unit: mm)

ABSOLUTE MAXIMUM RATINGS (TA = 25°C. All terminals are connected.)

PARAMETER	SYMBOL	N-CHANNEL	P-CHANNEL	UNIT
Drain to Source Voltage (Vgs = 0 V)	VDSS	40	-40	V
Gate to Source Voltage (V _{DS} = 0 V)	VGSS	±20	∓20	V
Drain Current (DC)	ID(DC)	±7	∓7	А
Drain Current (pulse) Note1	ID(pulse)	±28	∓28	А
Total Power Dissipation (1 unit) Note2	P _{T1}	1.7		W
Total Power Dissipation (2 units) Note2	Рт2	2.0		W
Channel Temperature	Tch	150		°C
Storage Temperature	Tstg	-55 to +150		°C
Single Avalanche Current Note3	las	7	-7	А
Single Avalanche Energy ^{Note3}	Eas	4.9		mJ

Notes 1. PW \leq 10 μ s, Duty Cycle \leq 1%

2. Mounted on ceramic substrate of 2000 $\text{mm}^2 \times 1.6 \text{ mm}$

3. Starting T_{ch} = 25°C, V_{DD} = 20 V, R_G = 25 Ω , L = 100 μ H, V_{GS} = 20 \rightarrow 0 V

ELECTRICAL CHARACTERISTICS (TA = 25°C. All terminals are connected.)

N-channel

NEC

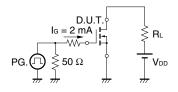
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	loss	V _{DS} = 40 V, V _{GS} = 0 V			10	μA
Gate Leakage Current	lgss	V _{GS} = ±20 V, V _{DS} = 0 V			±10	μA
Gate to Source Cut-off Voltage	V _{GS(off)}	V _{DS} = 10 V, I _D = 1 mA	1.5	2.0	2.5	V
Forward Transfer Admittance Note	y _{fs}	V _{DS} = 10 V, I _D = 3.5 A	4	8.5		S
Drain to Source On-state Resistance ^{Note}	RDS(on)1	V _{GS} = 10 V, I _D = 3.5 A		12	15	mΩ
	RDS(on)2	V _{GS} = 4.5 V, I _D = 3.5 A		16.5	23	mΩ
Input Capacitance	Ciss	V _{DS} = 10 V,		2200		pF
Output Capacitance	Coss	V _{GS} = 0 V,		320		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		190		pF
Turn-on Delay Time	td(on)	V _{DD} = 20 V, I _D = 3.5 A,		9.2		ns
Rise Time	tr	V _{GS} = 10 V,		22		ns
Turn-off Delay Time	td(off)	R _G = 0 Ω		54		ns
Fall Time	tr			10		ns
Total Gate Charge	Q _G	I _D = 7 A,		40		nC
Gate to Source Charge	Q _{GS}	V _{DD} = 32 V,		6		nC
Gate to Drain Charge	Qgd	V _{GS} = 10 V		12		nC
Body Diode Forward Voltage Note	VF(S-D)	IF = 7 A, VGS = 0 V		0.8	1.5	V
Reverse Recovery Time	trr	IF = 7 A, VGS = 0 V,		27		ns
Reverse Recovery Charge	Qrr	di/dt = 100 A/ <i>µ</i> s		21		nC

Note Pulsed

TEST CIRCUIT 1 AVALANCHE CAPABILITY

D.U.T ấг Rg = 25 Ω ~~~~ \leq 50 Ω PG. V_{DD} $V_{\text{GS}} = 20 \rightarrow 0 \ V$ BVDSS las VDD -Starting Tch

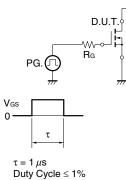
TEST CIRCUIT 3 GATE CHARGE

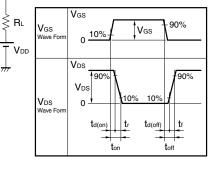


TEST CIRCUIT 2 SWITCHING TIME

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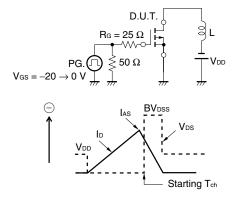
P-channel

CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	IDSS	V _{DS} = -40 V, V _{GS} = 0 V			-10	μA
Gate Leakage Current	lgss	V _{GS} = ∓20 V, V _{DS} = 0 V			∓10	μA
Gate to Source Cut-off Voltage	V _{GS(off)}	V _{DS} = -10 V, I _D = -1 mA	-1.0	-1.7	-2.5	V
Forward Transfer Admittance Note	y _{fs}	V _{DS} = -10 V, I _D = -3.5 A	5	11		S
Drain to Source On-state Resistance Note	RDS(on)1	V _{GS} = −10 V, I _D = −3.5 A		21	26	mΩ
	RDS(on)2	V _{GS} = -4.5 V, I _D = -3.5 A		24	36	mΩ
Input Capacitance	Ciss	V _{DS} = -10 V,		2200		pF
Output Capacitance	Coss	V _{GS} = 0 V,		350		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		260		pF
Turn-on Delay Time	td(on)	V_{DD} = -20 V, I _D = -3.5 A,		10		ns
Rise Time	tr	V _{GS} = -10 V,		18		ns
Turn-off Delay Time	td(off)	R _G = 0 Ω		150		ns
Fall Time	tr			26		ns
Total Gate Charge	QG	I _D = -7 A,		45		nC
Gate to Source Charge	QGS	$V_{DD} = -32 V,$		5.2		nC
Gate to Drain Charge	QGD	V _{GS} = -10 V		12		nC
Body Diode Forward Voltage Note	VF(S-D)	I _F = 7 A, V _{GS} = 0 V		0.84	1.5	V
Reverse Recovery Time	trr	$I_F = -7 \text{ A}, V_{GS} = 0 \text{ V},$		54		ns
Reverse Recovery Charge	Qrr	di/dt = –50 A/µs		25		nC

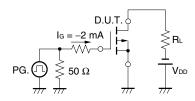
Note Pulsed

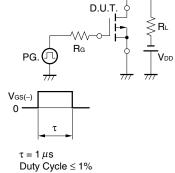
TEST CIRCUIT 1 AVALANCHE CAPABILITY

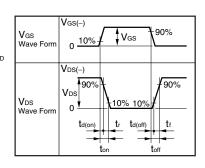
TEST CIRCUIT 2 SWITCHING TIME



TEST CIRCUIT 3 GATE CHARGE



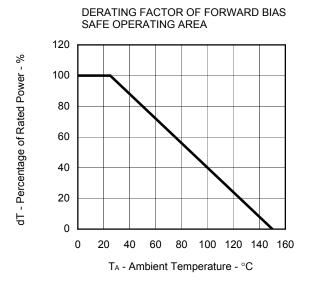




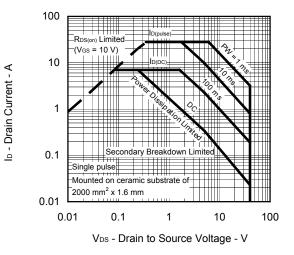
TYPICAL CHARACTERISTICS (TA = 25°C)

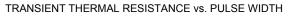
(1) N-channel

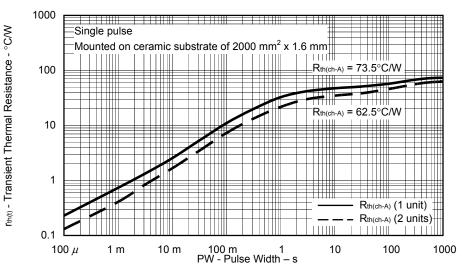
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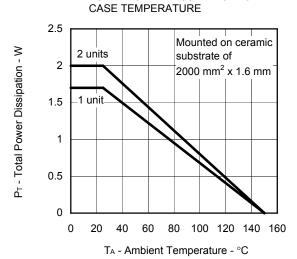






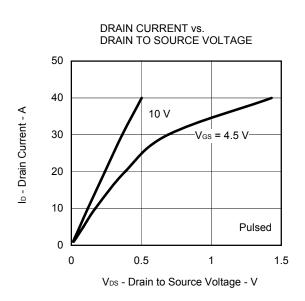




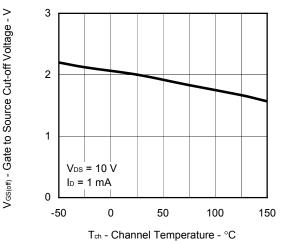


TOTAL POWER DISSIPATION vs.

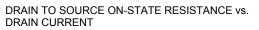
Data Sheet G19921EJ1V0DS

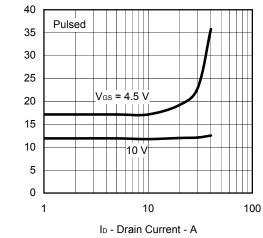




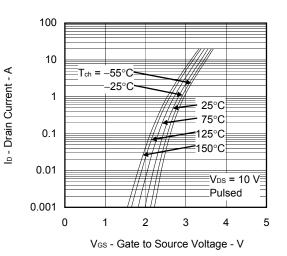




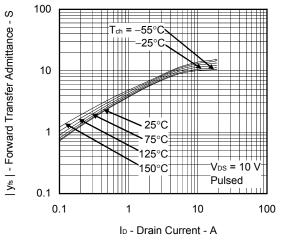




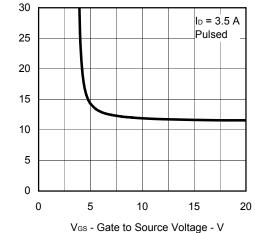
FORWARD TRANSFER CHARACTERISTICS



FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

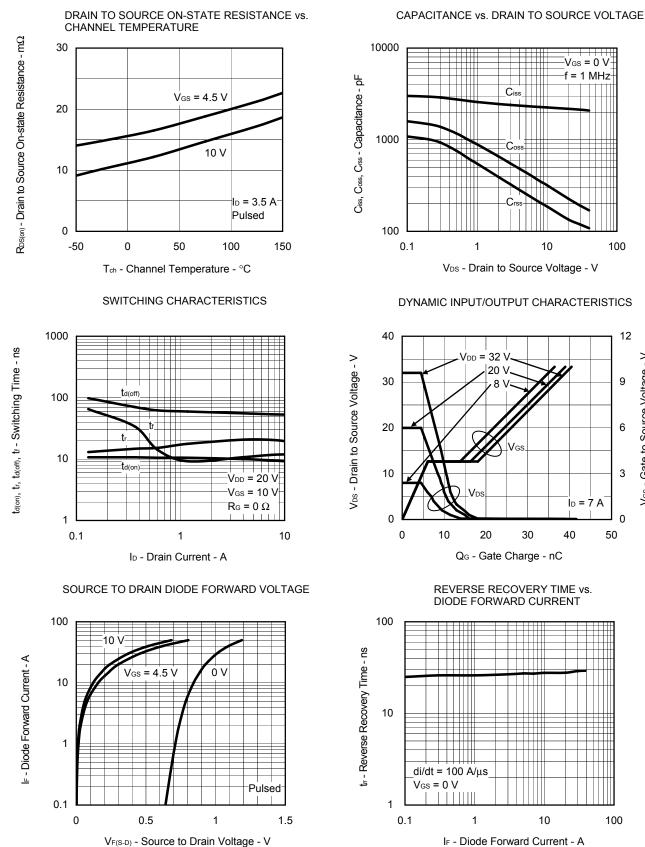


Data Sheet G19921EJ1V0DS

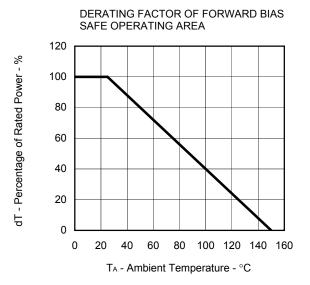
 $R_{DS(m)}$ - Drain to Source On-state Resistance - $m\Omega$

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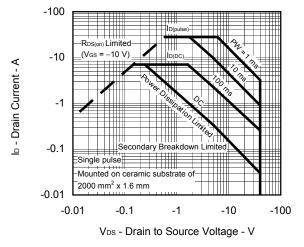
V_{GS} - Gate to Source Voltage - V

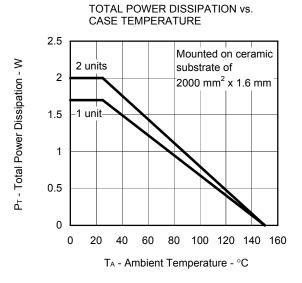


(2) P-channel

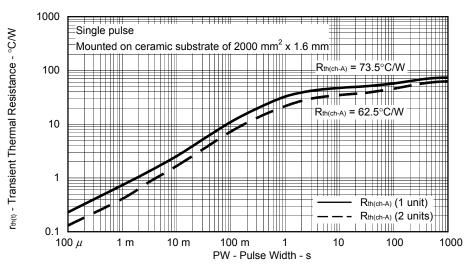


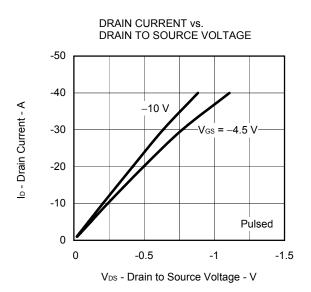
FORWARD BIAS SAFE OPERATING AREA



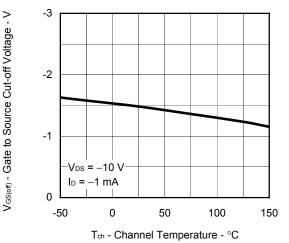


TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH

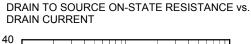


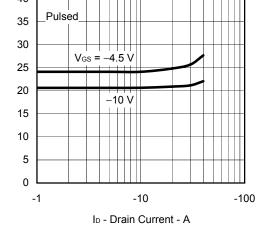




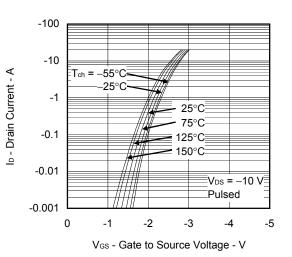




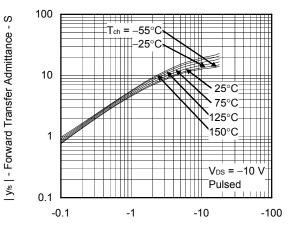




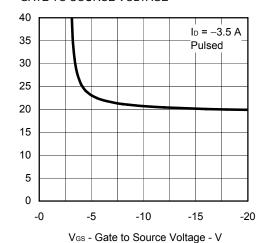
FORWARD TRANSFER CHARACTERISTICS



FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT

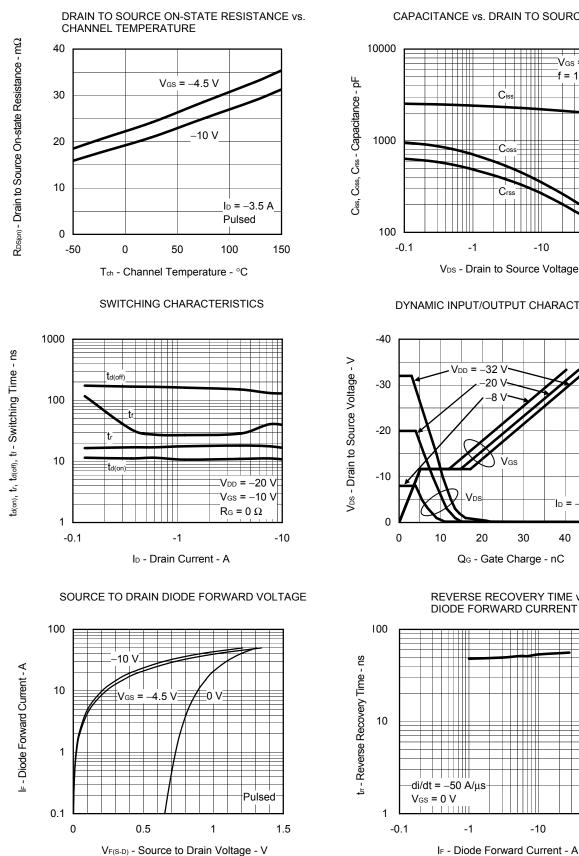






DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

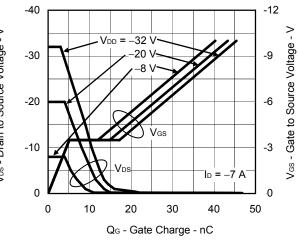
 $R_{DS(cn)}$ - Drain to Source On-state Resistance - $m\Omega$

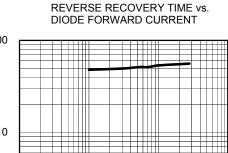


CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE

Vgs = 0 V f = 1 MHz Ciss Coss C -100 -10 VDS - Drain to Source Voltage - V

DYNAMIC INPUT/OUTPUT CHARACTERISTICS





-10

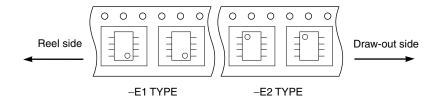
-100

Data Sheet G19921EJ1V0DS

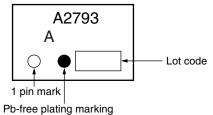
TAPE INFORMATION

NEC

There are two types (-E1, -E2) of taping depending on the direction of the device.



MARKING INFORMATION



RECOMMENDED SOLDERING CONDITIONS

The μ PA2793AGR should be soldered and mounted under the following recommended conditions.

For soldering methods and conditions other than those recommended below, please contact an NEC Electronics sales representative.

For technical information, see the following website.

Semiconductor Device Mount Manual (http://www.necel.com/pkg/en/mount/index.html)

Soldering Method	Soldering Conditions	Recommended Condition Symbol
Infrared reflow	reflow Maximum temperature (Package's surface temperature): 260°C or below	
	Time at maximum temperature: 10 seconds or less	
	Time of temperature higher than 220°C: 60 seconds or less	
	Preheating time at 160 to 180°C: 60 to 120 seconds	
	Maximum number of reflow processes: 3 times	
	Maximum chlorine content of rosin flux (percentage mass): 0.2% or less	
Partial heating	Maximum temperature (Pin temperature): 350°C or below	P350
	Time (per side of the device): 3 seconds or less	
	Maximum chlorine content of rosin flux: 0.2% (wt.) or less	

Caution Do not use different soldering methods together (except for partial heating).

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